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# AO4476A 30V N-Channel MOSFET

## **General Description**

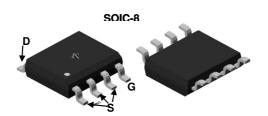
The AO4476A combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is suitable for use as a high side switch in SMPS and general purpose applications.

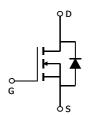
# **Product Summary**

 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 15A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 7.7 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} = 4.5V) & < 10.8 m\Omega \end{array}$ 

100% UIS Tested 100%  $R_g$  Tested







Absolute Maximum Ratings T <sub>A</sub> =25℃ unless otherwise noted						
Parameter		Symbol	Maximum	Units		
Drain-Source Voltage		V <sub>DS</sub>	30	V		
Gate-Source Voltage		$V_{GS}$	±20	V		
Continuous Drain	T <sub>A</sub> =25℃	1	15			
Current	T <sub>A</sub> =70℃	'D	12	Α		
Pulsed Drain Current <sup>C</sup>		I <sub>DM</sub>	110	7		
Avalanche Current <sup>C</sup>		I <sub>AS</sub> , I <sub>AR</sub>	27	A		
Avalanche energy L=0.1mH <sup>C</sup>		E <sub>AS</sub> , E <sub>AR</sub>	36	mJ		
	T <sub>A</sub> =25℃	P <sub>D</sub>	3.1	W		
Power Dissipation <sup>B</sup>	T <sub>A</sub> =70℃		2	VV		
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C		

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	D	31	40				
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	59	75				
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	16	24	℃/W			



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ =30V, $V_{GS}$ =0V				1	μΑ		
			T <sub>J</sub> =55℃			5	μ		
I <sub>GSS</sub>	Gate-Body leakage current		$V_{DS}$ =0V, $V_{GS}$ = ±20V			100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		1.5	1.98	2.5	V		
$I_{D(ON)}$	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V		110			Α		
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS}=10V$ , $I_D=15A$			6.4	7.7	mΩ		
			T <sub>J</sub> =125℃		10	12	11122		
		$V_{GS}$ =4.5V, $I_{D}$ =12A			8.6	10.8	$m\Omega$		
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =15A			45		S		
$V_{SD}$	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$			0.74	1	V		
I <sub>S</sub>	Maximum Body-Diode Continuous Current					4	Α		
DYNAMIC	PARAMETERS								
$C_{iss}$	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz		920	1150	1380	pF		
Coss	Output Capacitance			125	180	235	pF		
$C_{rss}$	Reverse Transfer Capacitance			60	105	150	pF		
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		0.55	1.1	1.65	Ω		
SWITCHII	NG PARAMETERS								
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =15A		16	20	24	nC		
Q <sub>g</sub> (4.5V)	Total Gate Charge			7.6	9.5	11.4	nC		
$Q_{gs}$	Gate Source Charge			2	2.7	3.2	nC		
$Q_{gd}$	Gate Drain Charge			3	5	7	nC		
t <sub>D(on)</sub>	Turn-On DelayTime				6.5		ns		
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =1 $\Omega$ , $R_{GEN}$ =3 $\Omega$			2		ns		
t <sub>D(off)</sub>	Turn-Off DelayTime				17		ns		
t <sub>f</sub>	Turn-Off Fall Time				3.5		ns		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =15A, dI/dt=500A/μs		7	8.7	10.5	ns		
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =15A, dI/dt=500A/μ	.s	11	13.5	16	nC		

A. The value of  $R_{\theta JA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using  $\leqslant$  10s junction-to-ambient thermal resistance.

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C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initialT<sub>.i</sub>=25° C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

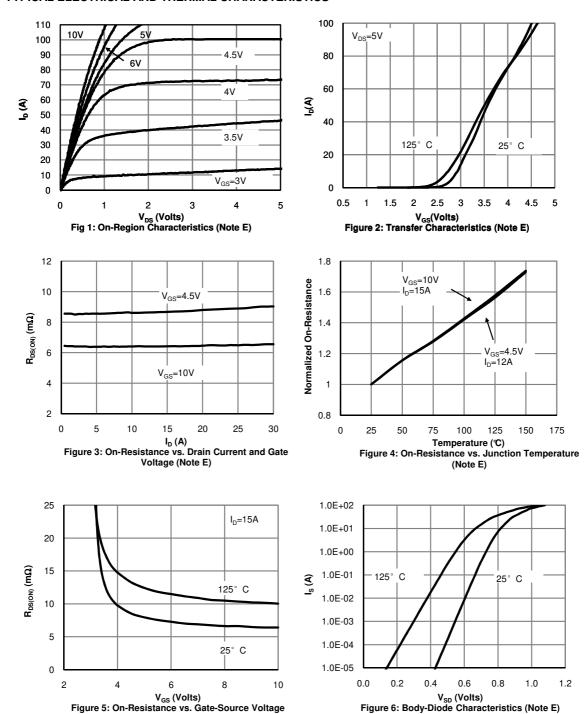
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J_j(MAX)}=150^\circ$  C. The SOA curve provides a single pulse rating.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)





#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

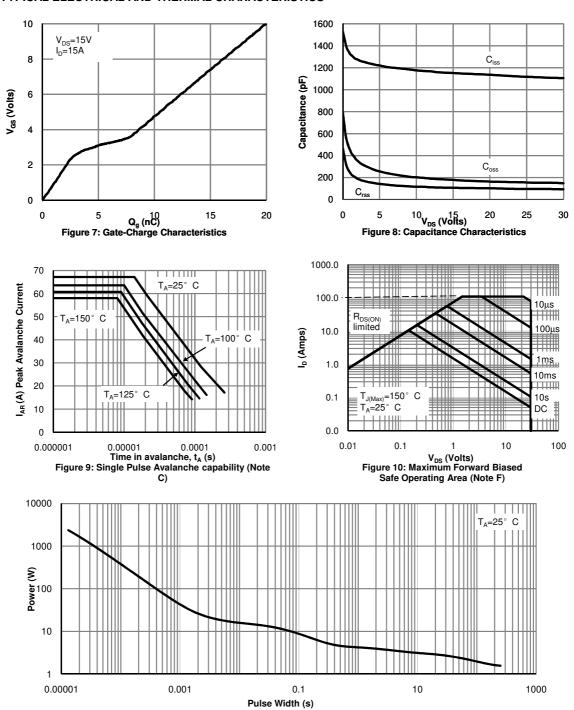
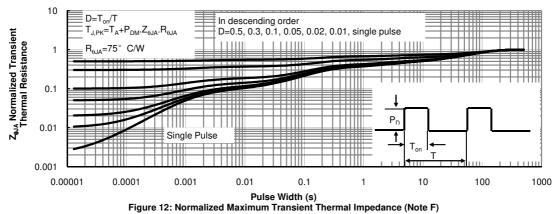


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

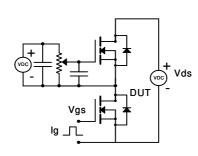


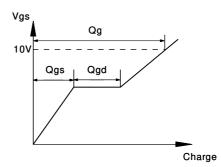
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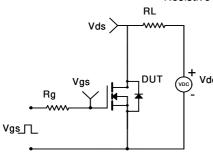


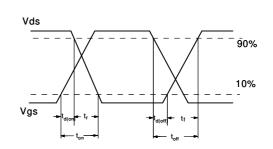
### Gate Charge Test Circuit & Waveform



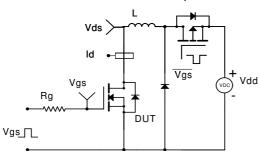


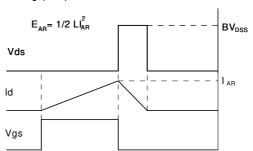
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

